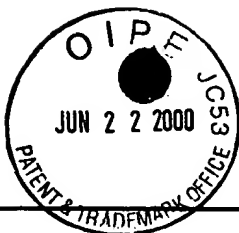


Form PTO-1449		Docket No: 112025-0112		Serial No. 09/216,519		
INFORMATION-DISCLOSURE		Applicant: Darren Kerr et al.				
STATEMENT		Filed: December 18, 1998		Group 2766		
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Examiner: gn				Date Considered: 9-01		
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STATEMENT		Filed: December 18, 1998		Group 2766			
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